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Fairchild Semiconductor FDZ209N

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May 2004

## FDZ209N

## 60V N-Channel PowerTrench® BGA MOSFET

### **General Description**

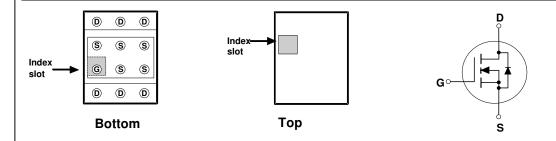
Combining Fairchild's advanced PowerTrench process with state-of-the-art BGA packaging, the FDZ209N minimizes both PCB space and  $R_{\text{DS}(\text{ON})}.$  This BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultra-low profile packaging, low gate charge, and low R<sub>DS(ON)</sub>.

#### **Applications**

· Solenoid Drivers

#### **Features**

- 4 A, 60 V.  $R_{DS(ON)} = 80 \text{ m}\Omega$  @  $V_{GS} = 5 \text{ V}$
- Occupies only 5 mm² of PCB area: only 55% of the area of SSOT-6
- Ultra-thin package: less than 0.80 mm height when mounted to PCB
- · Outstanding thermal transfer characteristics: 4 times better than SSOT-6
- Ultra-low Q<sub>g</sub> x R<sub>DS(ON)</sub> figure-of-merit
- · High power and current handling capability



## Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

			T		
Symbol	Parameter		Ratings	Units	
V <sub>DSS</sub>	Drain-Source Voltage		60	V	
V <sub>GSS</sub>	Gate-Source Voltage		±20	V	
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	4	Α	
	- Pulsed		20		
P <sub>D</sub>	Power Dissipation (Steady State)	(Note 1a)	2	W	
Tı, Teta	Operating and Storage Junction Temperature Range		-55 to +150	°C	

#### **Thermal Characteristics**

R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient	(Note 1a)	64	°C/W
R <sub>eJB</sub>	Thermal Resistance, Junction-to-Ball	(Note 1)	8	
R <sub>e,IC</sub>	Thermal Resistance, Junction-to-Case	(Note 1)	0.7	

Package Marking and Ordering Information

· acitage maritim	9 4.14 0.45.11.5				
Device Marking	Device	Reel Size	Tape width Quant		
209N	FDZ209N	7"	8mm	3000 units	

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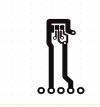
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-So	ource Avalanche Ratings (Note	e 2)	1			I
W <sub>DSS</sub>	Drain-Source Avalanche Energy	Single Pulse, $V_{DD} = 30 \text{ V}$ ,			90	mJ
I <sub>AR</sub>	Drain-Source Avalanche Current	I <sub>D</sub> = 4 A			4	Α
Off Char	acteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250  \mu\text{A}$	60			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C		59		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 48 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			1	μΑ
I <sub>GSS</sub>	Gate-Body Leakage.	$V_{GS} = \pm 20 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			±100	nA
On Chara	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	1	2.5	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C		-6		mV/°C
$R_{DS(on)}$	Static Drain–Source On–Resistance	$V_{GS} = 5 \text{ V}, \qquad I_D = 4 \text{ A} $ $V_{GS} = 5 \text{ V}, I_D = 4 \text{ A}, T_J = 125 ^{\circ}\text{C}$		60 91	80 130	mΩ
<b>g</b> FS	Forward Transconductance	$V_{DS} = 5 \text{ V}, \qquad I_D = 4 \text{ A}$		12		S
<b>Dynamic</b>	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 30 \text{ V}, \qquad V_{GS} = 0 \text{ V},$		657		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		76		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			32		pF
R <sub>G</sub>	Gate Resistance	$V_{GS} = 15 \text{ mV},  f = 1.0 \text{ MHz}$		1.5		Ω
Switchin	g Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 30 \text{ V}, \qquad I_{D} = 1 \text{ A},$		18	32	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = 5 \text{ V}, \qquad R_{GEN} = 6 \Omega$		4	8	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			15	27	ns
t <sub>f</sub>	Turn-Off Fall Time			8	16	ns
Qg	Total Gate Charge	$V_{DS} = 30 \text{ V}, \qquad I_{D} = 4 \text{ A},$		6.3	9	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = 5 \text{ V}$		2.5		nC
$Q_{gd}$	Gate-Drain Charge	1		2.5		nC
Drain-Sc	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source				1.7	Α
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V},  I_S = 1.7 \text{ A}  \text{(Note 2)}$		0.77	1.2	V
t <sub>rr</sub>	Diode Reverse Recovery Time	I <sub>F</sub> = 4A		27		nS
Q <sub>rr</sub>	Diode Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A}/\mu\text{s}$ (Note 2)		45		nC

Notes:

1. R<sub>eJA</sub> is determined with the device mounted on a 1 in<sup>2</sup> 2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. The thermal resistance from the junction to the circuit board side of the solder ball, R<sub>0,B'</sub> is defined for reference. For R<sub>0,C'</sub> the thermal reference point for the case is defined as the top surface of the copper chip carrier.  $R_{\theta JC}$  and  $R_{\theta JB}$  are guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design.



64 °C/W when mounted on a 1in² pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB

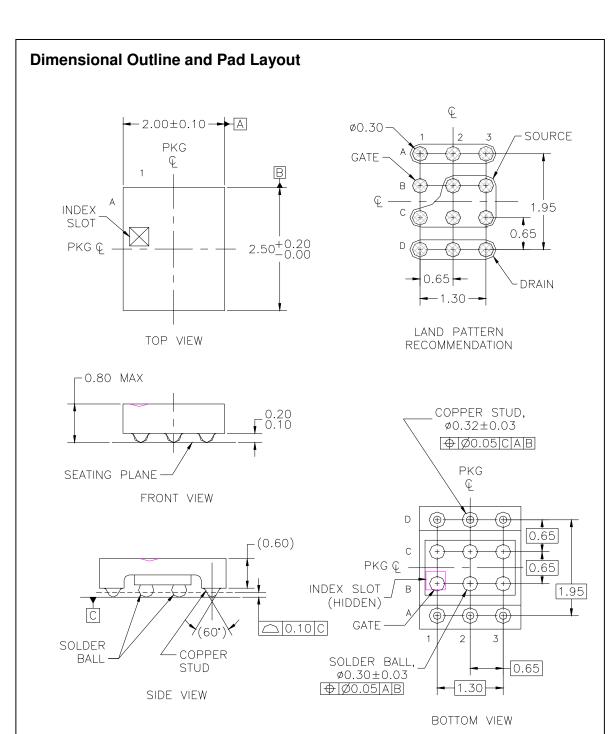


128 ℃/W when mounted on a minimum pad of 2 oz

Scale 1:1 on letter size paper

Pulse Test: Pulse Width < 300μs, Duty Cycle < 2.0%

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NOTES: UNLESS OTHERWISE SPECIFIED

- A) ALL DIMENSIONS ARE IN MILLIMETERS.
- B) NO JEDEC REGISTRATION REFERENCE AS OF JULY 1999.
- C) TERMINAL CONFIGURATION TABLE.

POSITION	DESIGNATION	TYPE
A1,A2,A3,	DRAIN	COPPER
D1,D2,D3	DIVAN	STUD
B1	GATE	SOLDER
B2,B3,C1,C2,C3	SOURCE	BALL



### **Typical Characteristics**

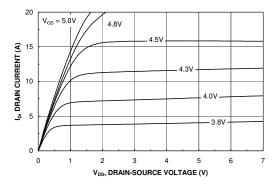


Figure 1. On-Region Characteristics.

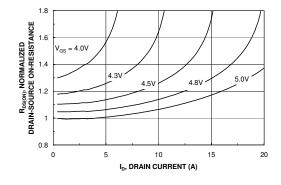


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

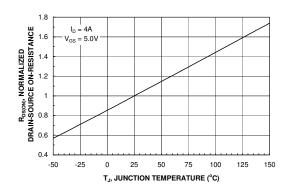


Figure 3. On-Resistance Variation with Temperature.

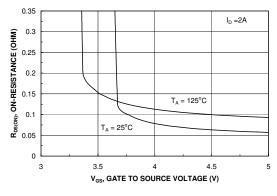


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

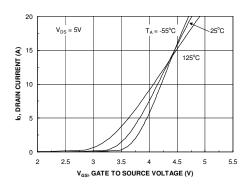


Figure 5. Transfer Characteristics.

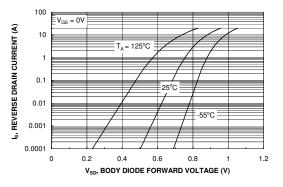
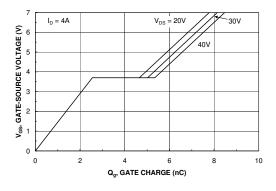


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.







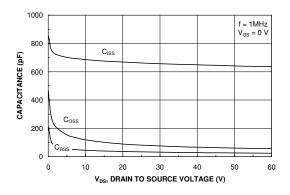
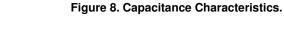
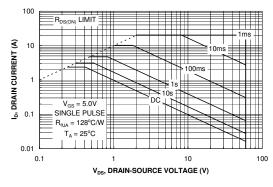


Figure 7. Gate Charge Characteristics.





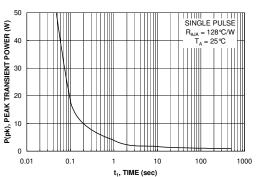


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

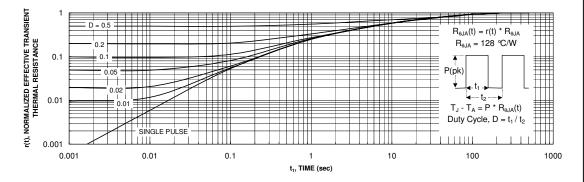


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.



# Distributor of Fairchild Semiconductor: Excellent Integrated System Limited Datasheet of FDZ209N - MOSFET N-CH 60V 4A 12-BGA

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EnSigna™	<i>i-</i> Lo <sup>™</sup>	$OCX^{TM}$	RapidConnect™	UHC™
FACT™	ImpliedDisconnect™	OCXPro <sup>™</sup>	μSerDes™	UltraFET®
<b>FACT Quiet Serie</b>	es <sup>™</sup>	OPTOLOGIC®	SILENT SWITCHER®	VCX <sup>TM</sup>
Across the board The Power France Programmable A		OPTOPLANAR <sup>TM</sup> PACMAN <sup>TM</sup> POP <sup>TM</sup>	SMART START <sup>TM</sup> SPM <sup>TM</sup> Stealth <sup>TM</sup>	

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